PATENT

rney Docket No. 5649.1159

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re: Gi-ho Park

Application Serial No.: 10/801,893

Group Art Unit: 2171 Filed: March 16, 2004 Confirmation No.: 3389

For: METHODS, CIRCUITS, AND SYSTEMS FOR UTILIZING IDLE TIME IN

DYNAMIC FREQUENCY SCALING CACHE MEMORIES

January 25, 2005

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97(b)

Sir:

JAN 2 7 2005

Attached is a list of documents on Form PTO-1449, together with a copy of any listed foreign patent document and/or non-patent literature. A copy of any listed U.S. patent and/or U.S. patent application publication is not provided herewith in accordance with the amendment by the U.S. Patent and Trademark Office to 37 C.F.R. § 1.98(a)(2)(ii) effective October 21, 2004.

It is requested that these documents be considered by the Examiner and officially made of record in accordance with the provisions of 37 C.F.R. § 1.56 and Section 609 of the MPEP.

No fee is believed due. However, the Commissioner is hereby authorized to charge any deficiency or credit any overpayment to Deposit Account No. 50-0220.

Respectfully submitted,

Bobert N. Crouse

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I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to: Mail Stop Amendment. Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on January 25, 2005.

Elizabeth J. Porter

Substitute form 1449A/PTO							Complete if Known Application Number 10/801,893						
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STATEMENT BY APPLICANT							First Named Inventor Gi-ho Park					<u>, o/</u>	
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